

Notice of References Cited	Application/Control No. 09/537,812	Applicant(s)/Patent Under Reexamination White et al.	
	Examiner Rafael Perez-Gutierrez	Art Unit 2686	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,900,564	05-1999	Kurakake	84/477 R
*	B	US-6,516,466 B1	02-2003	Jackson	455/3.01
*	C	US-6,721,710 B1	04-2004	Lueck et al.	369/59.21
*	D	US-2004/0078274 A1	04-2004	Aarnio	705/26
*	E	US-2005/0054379 A1	03-2005	Cao et al.	455/556.1
*	F	US-6,956,833 B1	10-2005	Yukie et al.	370/352
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	98/19480 ✓	05-1998	WIPO	Valentine et al.	H04Q 7/22
	O	10-173737 ✓	06-1998	Japan	Emiko	H04M 1/00
	P	0 898 378 ✓	02-1999	Europe	Ito	H04B 1/20
	Q	1999-024210 ✓	03-1999	Korea	Kim	H04L 12/58
	R	1999-0033726 ✓	05-1999	Korea	Kim	H04B 1/40
	S	99/43136 ✓	08-1999	WIPO	Rydbeck et al.	H04M 1/72
	T	00/38340 ✓	06-2000	WIPO	Kim	H04B 1/40

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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